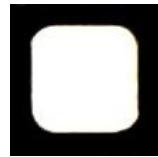


Silicon Carbide Power Schottky Diode

V_{RRM}	= 650 V
I_F @ 25 °C	= 100 A
Q_C	= 158 nC

Features

- 650 V Schottky rectifier
- 175 °C maximum operating temperature
- Temperature independent switching behavior
- Superior surge current capability
- Positive temperature coefficient of V_F
- Extremely fast switching speeds
- Superior figure of merit Q_C/I_F



Die Size = 4.5 mm x 4.5 mm

Advantages

- Improved circuit efficiency (Lower overall cost)
- Low switching losses
- Ease of paralleling devices without thermal runaway
- Smaller heat sink requirements
- Low reverse recovery current
- Low device capacitance
- Low reverse leakage current at operating temperature

Applications

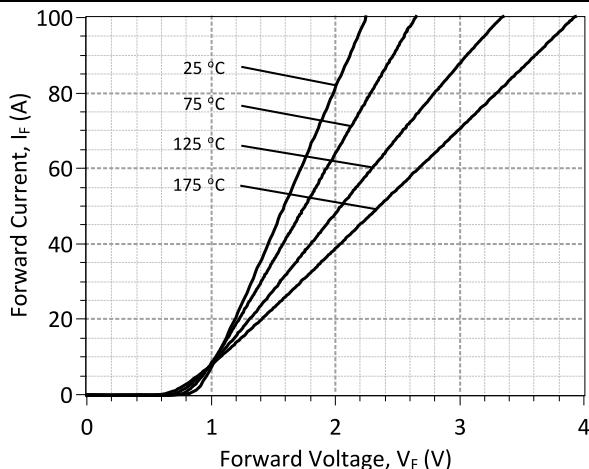
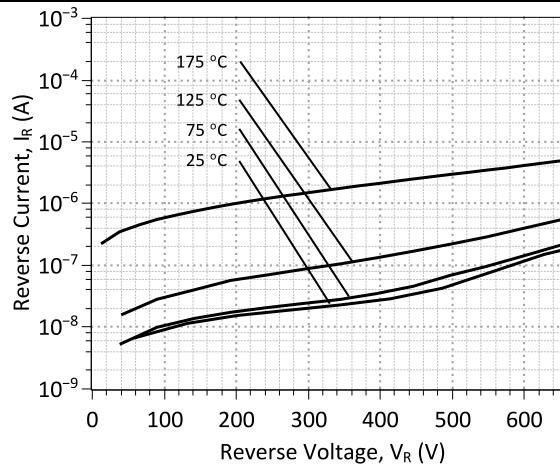
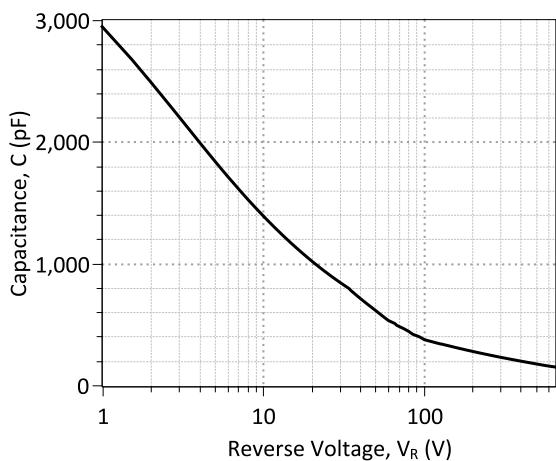
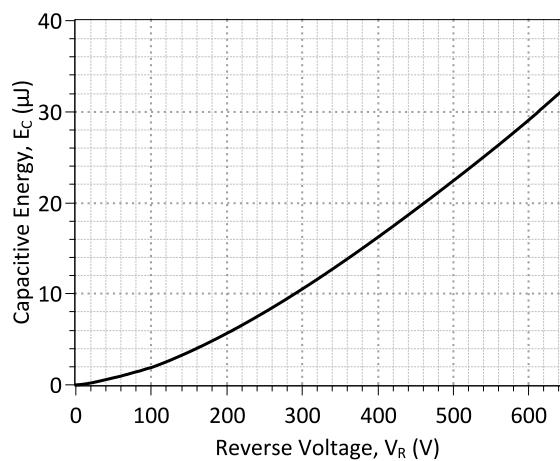
- Automotive Traction Inverters
- Power Factor Correction (PFC)
- Switched-Mode Power Supply (SMPS)
- Solar Inverters
- Wind Turbine Inverters
- Motor Drives
- Induction Heating
- Uninterruptible Power Supply (UPS)

Maximum Ratings at T_j = 175 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Repetitive peak reverse voltage	V _{RRM}		650	V
Continuous forward current	I _F	T _C = 25 °C, R _{thJC} = 0.24	100	A
Continuous forward current	I _F	T _C ≤ 135 °C, R _{thJC} = 0.24	50	A
RMS forward current	I _{F(RMS)}	T _C ≤ 135 °C, R _{thJC} = 0.24	87	A
Surge non-repetitive forward current, Half Sine Wave	I _{F,SM}	T _C = 25 °C, t _P = 10 ms T _C = 135 °C, t _P = 10 ms	350 313	A
Non-repetitive peak forward current	I _{F,max}	T _C = 25 °C, t _P = 10 µs	1625	A
I ² t value	∫I ² dt	T _C = 25 °C, t _P = 10 ms T _C = 135 °C, t _P = 10 ms	450 300	A ² s
Power dissipation	P _{tot}	T _C = 25 °C, R _{thJC} = 0.24	620	W
Operating and storage temperature	T _j , T _{stg}		-55 to 175	°C

Electrical Characteristics at T_j = 175 °C, unless otherwise specified

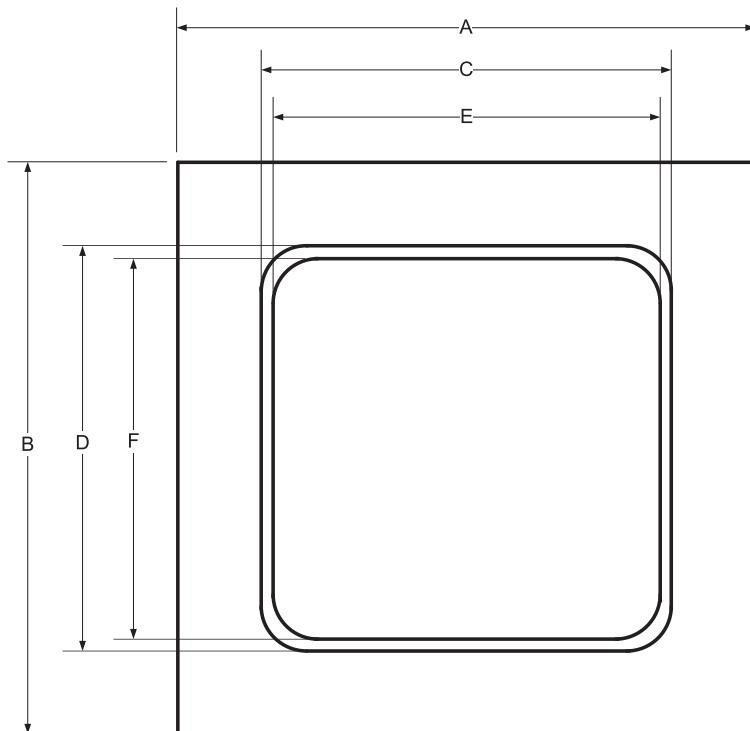
Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Diode forward voltage	V _F	I _F = 50 A, T _j = 25 °C	1.5	1.8	3.0	V
		I _F = 50 A, T _j = 175 °C	2.4			
Reverse current	I _R	V _R = 650 V, T _j = 25 °C	1	100	500	µA
		V _R = 650 V, T _j = 175 °C	10			
Total capacitive charge	Q _C	I _F ≤ I _{F,MAX} dI/dt = 200 A/µs	158			nC
Switching time	t _s	T _j = 175 °C	50			ns
		V _R = 1 V, f = 1 MHz, T _j = 25 °C V _R = 400 V, f = 1 MHz, T _j = 25 °C V _R = 650 V, f = 1 MHz, T _j = 25 °C	2940 203 155			pF

Figures:

Figure 1: Typical Forward Characteristics

Figure 2: Typical Reverse Characteristics

Figure 3: Typical Junction Capacitance vs Reverse Voltage Characteristics

Figure 4: Typical Capacitive Energy vs Reverse Voltage Characteristics

Mechanical Parameters

Die Dimensions	4.5 x 4.5	mm ²
Anode Pad Size	4.24 x 4.24	
Die Area total / active	20.25/17.64	
Die Thickness	360	µm
Wafer Size	100	mm
Flat Position	0	deg
Die Frontside Passivation	Polyimide	
Anode Pad Metallization	4000 nm Al	
Backside Cathode Metallization	400 nm Ni + 200 nm Au	
Die Attach	Electrically conductive glue or solder	
Wire Bond	Al ≤ 380 µm	
Reject ink dot size	Φ ≥ 0.3 mm	
Recommended storage environment	Store in original container, in dry nitrogen, < 6 months at an ambient temperature of 23 °C	

Chip Dimensions:



DIE	A [mm]	4.5
	B [mm]	4.5
METAL	C [mm]	4.24
	D [mm]	4.24
WIRE BONDABLE	E [mm]	4.2
	F [mm]	4.2



Die Datasheet

GB50SLT06-CAL

Revision History			
Date	Revision	Comments	Supersedes
2015/02/12	3	Inserted Mechanical Parameters	
2014/09/12	2	Updated Electrical Characteristics	
2013/11/12	1	Updated Electrical Characteristics	
2013/09/18	0	Initial Release	

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SPICE Model Parameters

This is a secure document. Please copy this code from the SPICE model PDF file on our website (http://www.genesicsemi.com/images/hit_sic/baredie/schottky/GB50SLT06-CAL_SPICE.pdf) into LTSpice (version 4) software for simulation of the GA50SLT06-CAL.

```
*      MODEL OF GeneSiC Semiconductor Inc.  
*  
*      $Revision: 1.0          $  
*      $Date: 20-SEP-2013      $  
*  
*      GeneSiC Semiconductor Inc.  
*      43670 Trade Center Place Ste. 155  
*      Dulles, VA 20166  
*  
*      COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.  
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* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY OF ANY  
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* WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE."  
* Models accurate up to 2 times rated drain current.  
*  
* Start of GB50SLT06-CAL SPICE Model  
*.SUBCKT GB50SLT06 ANODE KATHODE  
D1 ANODE KATHODE GB50SLT06_SCHOTTKY  
D2 ANODE KATHODE GB50SLT06_SURGE  
.MODEL GB50SLT06_SCHOTTKY D  
+ IS      1.99E-16      RS      0.015652965  
+ N       1             IKF     1000  
+ EG      1.2           XTI     3  
+ TRS1    0.0042        TRS2    1.3E-05  
+ CJO     3.86E-09      VJ      1.362328465  
+ M       0.48198551    FC      0.5  
+ TT      1.00E-10      BV      650  
+ IBV    1.00E-03       VPK     650  
+ IAVE    50            TYPE    Sic_Schottky  
+ MFG     GeneSiC_Semi  
.MODEL GB50SLT06_SURGE D  
+ IS      1.54E-19      RS      0.1  
+ TRS1   -0.004         N       3.941  
+ EG      3.23           IKF     19  
+ XTI     0              FC      0.5  
+ TT      0              BV      650  
+ IBV    1.00E-03       VPK     650  
+ IAVE    50            TYPE    Sic_PiN  
.ENDS  
*  
* End of GB50SLT06-CAL SPICE Model
```